

SSCU78P100GT4

N-Channel Enhancement Mode MOSFET

Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	l _D
100\/	1.00)/	78mΩ@-10V	264
-100V	±20V	84mΩ@-4.5V	-36A

> Description

This device is P-Channel enhancement MOSFET.

Uses trench technology and design to provide excellent RDSON with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit.

100% UIS + ΔVDS + Rg Tested!

Applications

- Load Switch
- PWM Application
- Power Management
- DC-DC Conversion

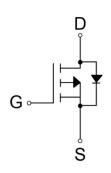
Ordering Information

Device	Package	Shipping	
SSCU78P100GT4	TO-220-3L	50/Tube	

> Pin configuration



TO-220-3L (Top View)



Pin Configuration



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V_{DSS}	Drain-to-Source Voltage		-100	V
V_{GSS}	Gate-to-Source Volta	ge	±20	V
	Continuous Dunin Comment d	T _C =25℃	-36	Δ.
I _D	Continuous Drain Current ^d	T _C =100℃	-18	- A
	Cartinua Dania Comant 2	T _A =25℃	-4.5	Δ.
IDSM	I _{DSM} Continuous Drain Current ^a T _A =70 I _{DM} Pulsed Drain Current ^b	T _A =70°C	-3.2	- A
I _{DM}	Pulsed Drain Curren	Pulsed Drain Current b		Α
Б	Danier Diagination C	Tc=25℃	148	10/
P _D	Power Dissipation °	T _C =100℃	60	W
	Danier Diagination 2	T _A =25℃	2.5	10/
P _{DSM}	Power Dissipation ^a	T _A =70°C	1.6	- W
las	Avalanche Current ^b L=0.5mH Single Pulse		-20	Α
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		100	mJ
TJ	Operation junction temperature		-55~150	°C
T _{STG}	Storage temperature ra	ange	-55~150	℃

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance a	50	°C /\\/
Rejc	Junction-to-Case Thermal Resistance	0.85	°C/W

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25 °C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.1 www.sscsemi.com Analog Future



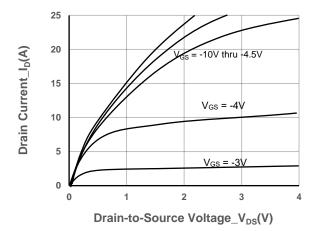
SSCU78P100GT4

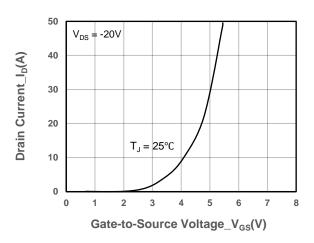
\succ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250μA	-100			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250uA$	-1.1	-1.6	-2.5	V
Drain-Source On-Resistance	D	V _{GS} = -10V, I _D = -20A		78	105	m0
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -4.5V, I _D = -10A		84	135	mΩ
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -100V, V _{GS} = 0V			-1	μA
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = -10V, I _D = -10A		25		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = -10A		-0.7	-1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		6.5		Ω
Input Capacitance	Ciss	V = 20V V = 0V		3210		
Output Capacitance	Coss	$V_{DS} = -30V$, $V_{GS} = 0V$, $f = 1MHz$		120		pF
Reverse Transfer Capacitance	Crss	I – IIVIMZ		116		
Total Gate Charge	Q _G	V - 40V/V - 50V		49		
Gate to Source Charge	Q _G s	$V_{GS} = -10V, V_{DS} = -50V,$ $I_{D} = -20A$		8.5		nC
Gate to Drain Charge	Q _{GD}	1D – -2UA		6		
Turn-on Delay Time	T _{D(ON)}			12		
Rise Time	Tr	V _{GS} = -10V, V _{DS} =- 30V,		26		20
Turn-off Delay Time	T _{D(OFF)}	$I_D = -10A, R_G = 30\Omega,$		78		ns
Fall Time	T _f			50		

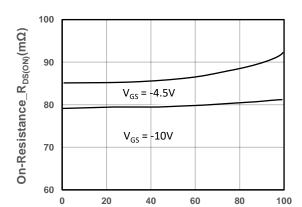


> Typical Performance Characteristics (T_A=25℃ unless otherwise noted)

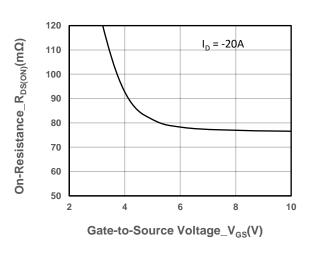




Output Characteristics

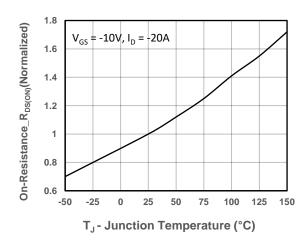


Transfer Characteristics

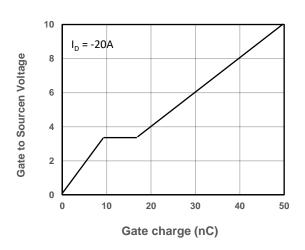


On-Resistance vs. Drain Current and Gate Voltag

Drain Current_I_D(A)



On-Resistance vs. Gate-to-Source Voltage

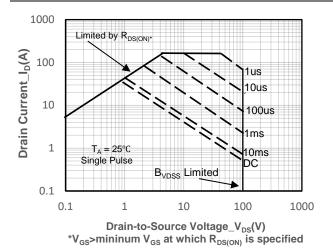


On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge

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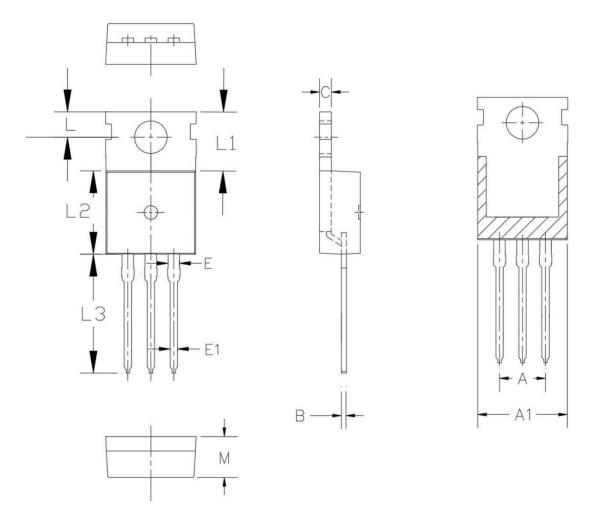




Safe Operating Area vs. Junction-to-Ambient



Package Information



Symbol	MILL IMETER			
Symbol	Min	Nom	Max	
А	5.08 BSC			
A1	9.00	10.00	11.00	
В	0.33		0.65	
С	1.20		1.40	
E	1.17		1.37	
E1	0.60		1.10	
L	2.50		3.00	
L1	6.3	6.5	6.7	
L2	8.95		9.75	
L3	12.88		13.40	
M	4.30		4.70	



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